

Search Notes

Application/Control No.

10/017,174

Examiner

Binh Q. Nguyen

Applicant(s)/Patent under
Reexamination

DELL ET AL.

Art Unit

2664

SEARCHED

Class	Subclass	Date	Examiner
370	422	7/12/2005	BQN
370	380	7/12/2005	BQN
370	388	7/12/2005	BQN
370	427	7/12/2005	BQN
370	366	7/13/2005	BQN
370	367	7/12/2005	BQN
340	2.22	7/12/2005	BQN
340	2.24	7/14/2005	BQN
340	2.26	7/12/2005	BQN

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST, consulted with Wellington Chin	7/12/2005	BQN